## Notice of References Cited Application/Control No. 10/729,501 Examiner Alexis Boateng Applicant(s)/Patent Under Reexamination WOZNIAK, JOHN A. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,060,185	05-2000	Okutoh, Tadashi	429/7
	В	US-6,501,248	12-2002	Fujiwara, Akihiko	320/136
	С	US-6,285,165	09-2001	Terada, Yukihiro	320/134
	D	US-5,963,019	10-1999	Cheon, Kyung-Yong	320/150
	Е	US-2004/0062387	04-2004	O'Connor, Gavin Paul	379/412
	F	US-6,046,575	04-2000	Demuro, David M.	320/134
	G	US-2003/0080747	05-2003	Huelss, Rolf	324/426
	Н	US-2003/0117143	06-2003	Okada, Tetsuya	324/428
	ı	US-6,492,791	12-2002	Saeki et al.	320/135
	J	US-6,804,100	10-2004	Astala, Jari	361/93.2
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α		į.			
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.